

<b>Notice of References Cited</b>	Application/Control No. 10/551,845	Applicant(s)/Patent Under Reexamination SON ET AL.	
	Examiner Dameon E. Levi	Art Unit 2841	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,224,391	05-2001	Horie et al.	439/64
*	B	US-6,327,154	12-2001	Gauld et al.	361/737
*	C	US-6,122,175	09-2000	Shieh, Ron-Yen	361/737
*	D	US-6,574,112	06-2003	Washino et al.	361/752
*	E	US-5,517,387	05-1996	Smith, Michael G.	361/686
*	F	US-6,337,797	01-2002	Huang, Tzu-Sung	361/737
*	G	US-6,413,108	07-2002	Centofante, Charles A.	439/267
*	H	US-6,008,994	12-1999	Bates, Charles Lindsay	361/737
*	I	US-6,903,935	06-2005	Chen, Tien-Tzu	361/737
*	J	US-5,846,092	12-1998	Feldman et al.	439/76.1
*	K	US-7,059,913	06-2006	Chen, George	439/638
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.